

## N-Channel Super Trench Power MOSFET

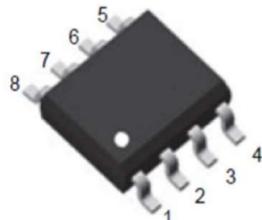
### Features

- $V_{DS} = 150V$ ,  $I_D = 5.1A$
- $R_{DS(ON)} < 55 \text{ m}\Omega @ V_{GS} = 10V$
- $R_{DS(ON)} < 65 \text{ m}\Omega @ V_{GS} = 4.5V$

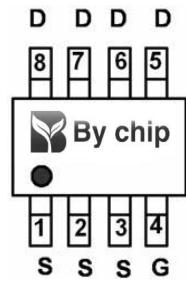
### General Features

- Advanced Trench Technology
- Provide Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead Free and Green Available

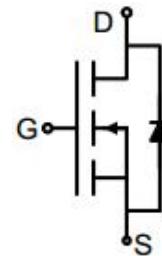
100% UIS TESTED!  
100%  $\Delta V_{ds}$  TESTED!



SOP-8



pin assignment



Schematic diagram

### Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	150	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	5.1	A
Drain Current-Continuous( $T_C=100^\circ\text{C}$ )	$I_D(100^\circ\text{C})$	3.6	A
Pulsed Drain Current <sup>(Note 1)</sup>	$I_{DM}$	20	A
Single pulse avalanche energy <sup>(Note 5)</sup>	$E_{AS}$	60	mJ
Maximum Power Dissipation  $T_C = 25^\circ\text{C}$	$P_D$	5	W
		3	W
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 150	°C

### Thermal Characteristic

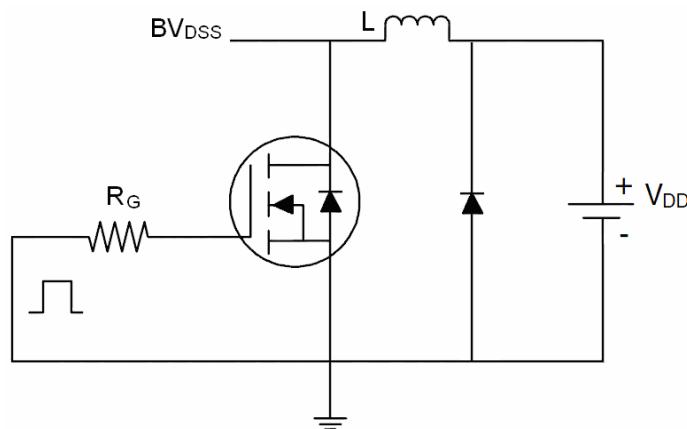
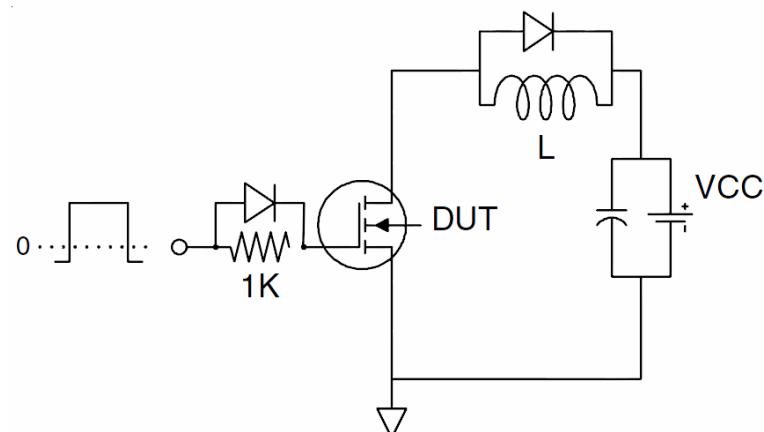
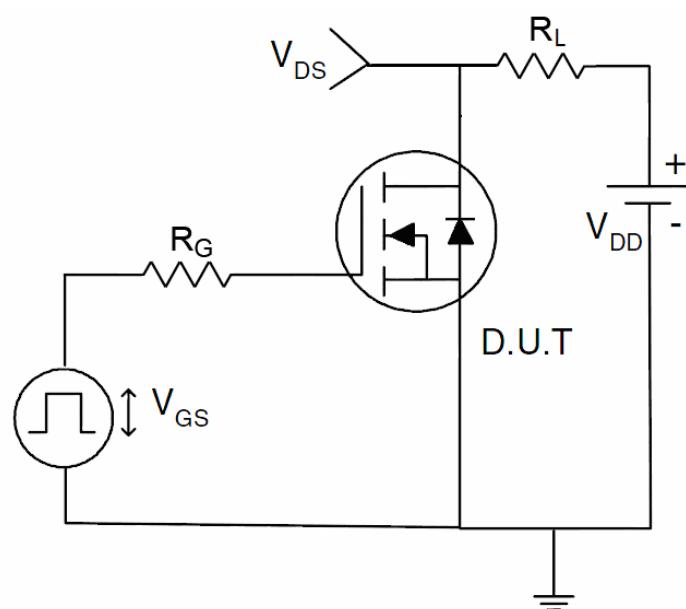
Thermal Resistance, Junction-to-Ambient <sup>(Note 2)</sup>	$R_{\theta JA}$	41.7	°C/W
Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	$R_{\theta JC}$	25	

**Electrical Characteristics ( $T_A=25^\circ\text{C}$  unless otherwise noted)**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	150	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=150\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b> (Note 3)						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0		4.5	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=5.1\text{A}$	-		55	$\text{m}\Omega$
Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=5.1\text{A}$	-	12.5	-	S
<b>Dynamic Characteristics</b> (Note 4)						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=75\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	618	850	PF
Output Capacitance	$C_{\text{oss}}$		-	81	105	PF
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	6.5	9	PF
<b>Switching Characteristics</b> (Note 4)						
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=75\text{V}, I_{\text{D}}=5.1\text{A}$ $V_{\text{GS}}=10\text{V}, R_{\text{G}}=3\Omega$	-	12.8	14	nS
Turn-on Rise Time	$t_{\text{r}}$		-	1.4	8.5	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	12.5	21	nS
Turn-Off Fall Time	$t_{\text{f}}$		-	2.5	8.0	nS
Total Gate Charge	$Q_{\text{g}}$	$V_{\text{DS}}=75\text{V}, I_{\text{D}}=5.1\text{A}, V_{\text{GS}}=10\text{V}$	-	12.8	18.0	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	5		nC
Gate-Drain Charge	$Q_{\text{gd}}$		-	3.6		nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage (Note 3)	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=5.1\text{A}$	-	-	1.2	V
Diode Forward Current (Note 2)	$I_{\text{S}}$		-	-	5.1	A
Reverse Recovery Time	$t_{\text{rr}}$	$T_J = 25^\circ\text{C}, I_F = I_S$ $dI/dt = 100\text{A}/\mu\text{s}$ (Note 3)	-	58	95	nS
Reverse Recovery Charge	$Q_{\text{rr}}$		-	69	110	nC

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. The value of  $R_{\text{GJA}}$  is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production
5. EAS condition :  $T_J=25^\circ\text{C}, V_{\text{DD}}=50\text{V}, V_{\text{G}}=10\text{V}, L=0.5\text{mH}, R_g=25\Omega$

**Test Circuit****1) E<sub>AS</sub> test Circuit****2) Gate charge test Circuit****3) Switch Time Test Circuit**

### Typical Electrical and Thermal Characteristics (Curves)

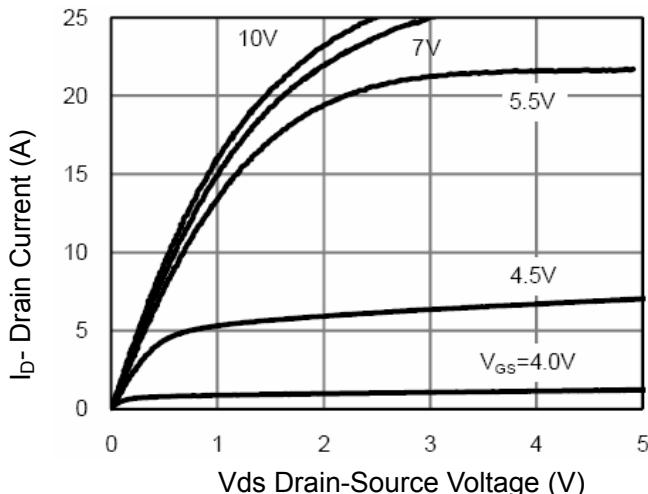


Figure 1 Output Characteristics

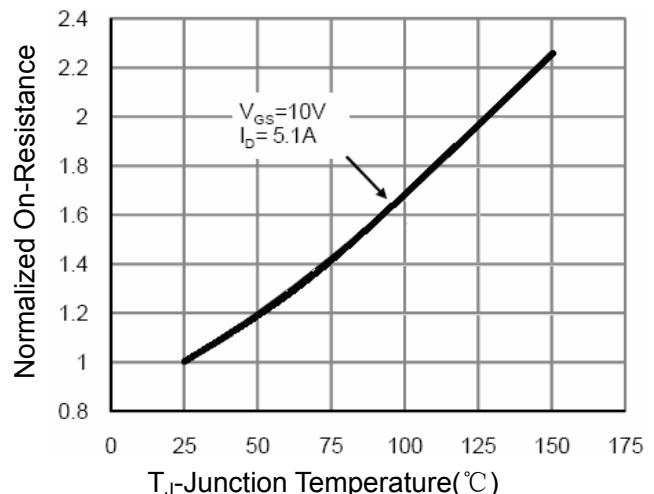


Figure 4  $R_{DS(on)}$ -Junction Temperature

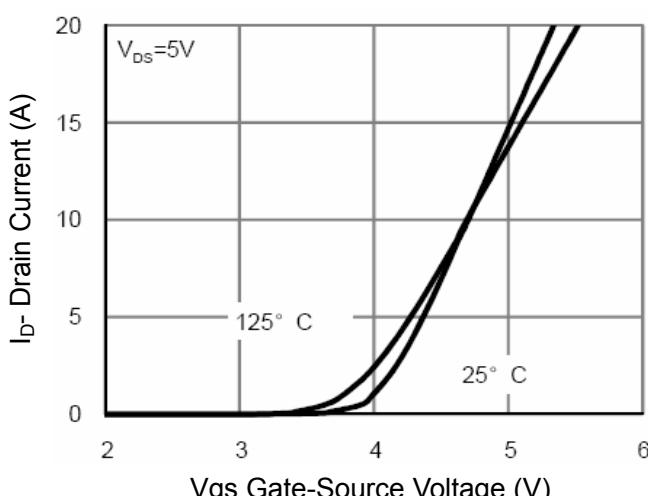


Figure 2 Transfer Characteristics

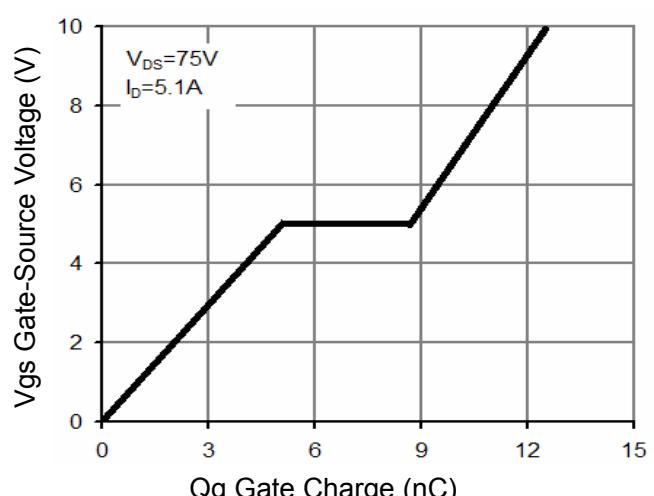


Figure 5 Gate Charge

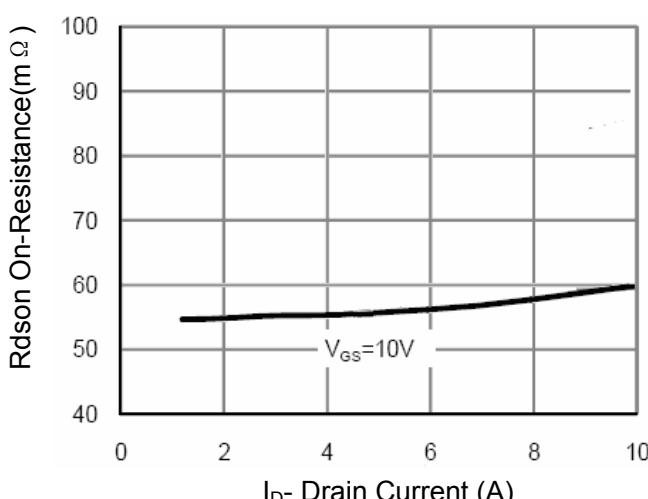


Figure 3  $R_{DS(on)}$ - Drain Current

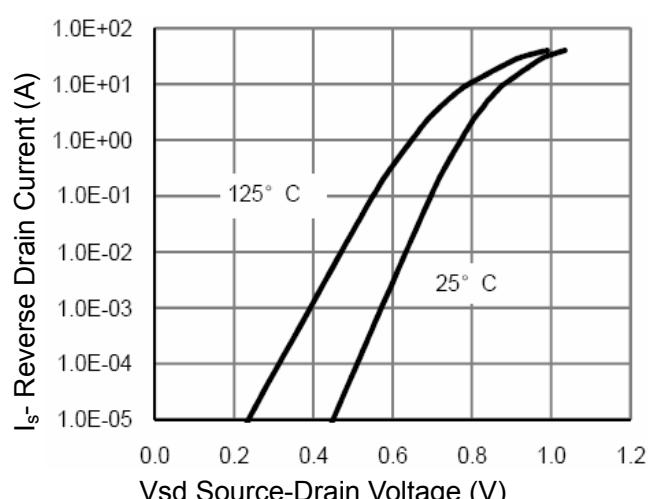
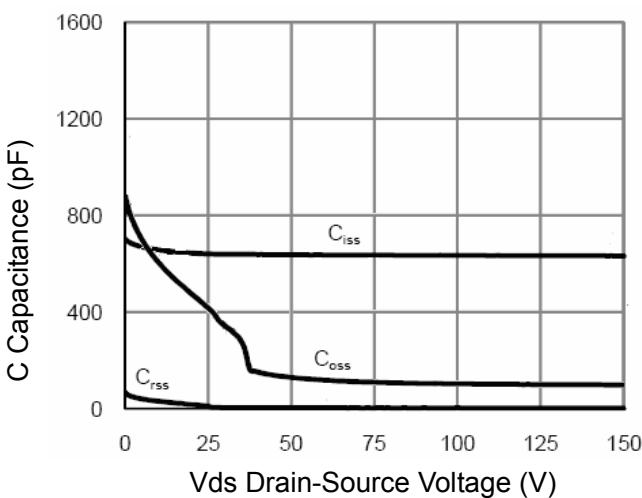
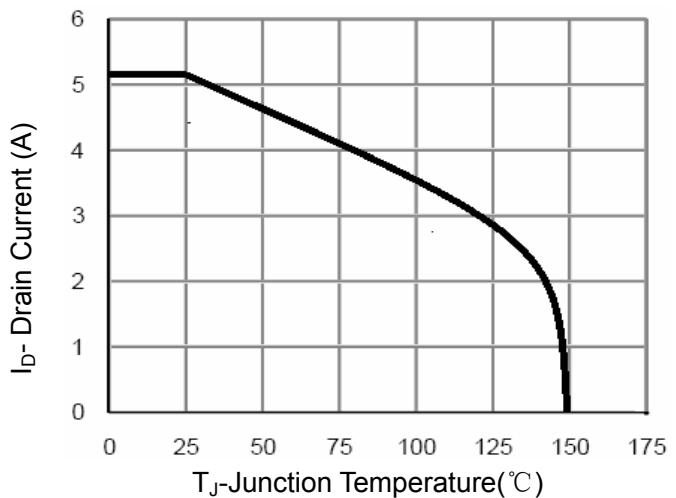
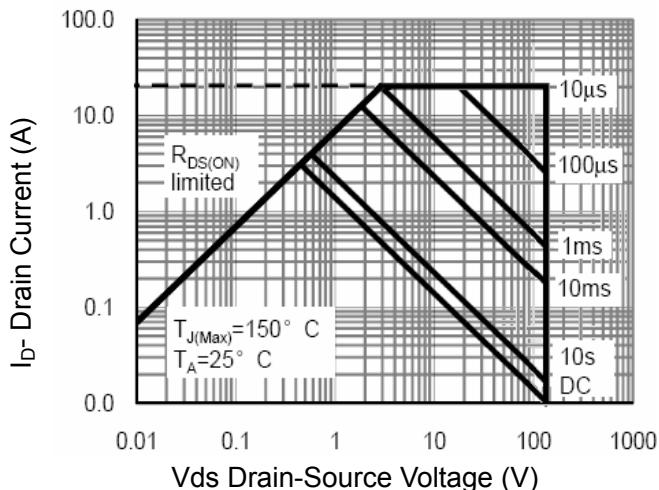
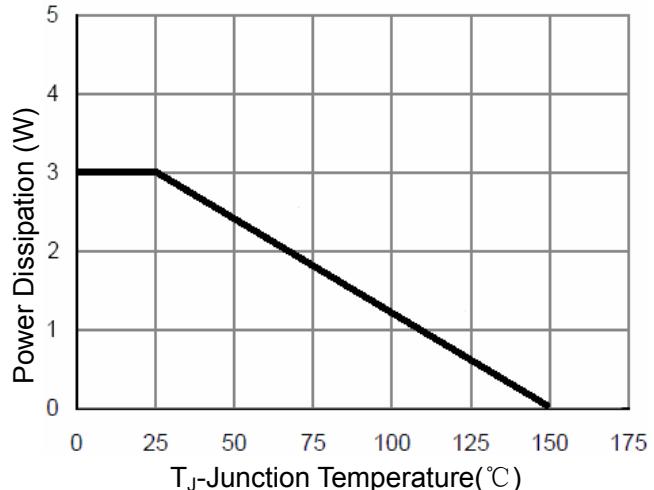
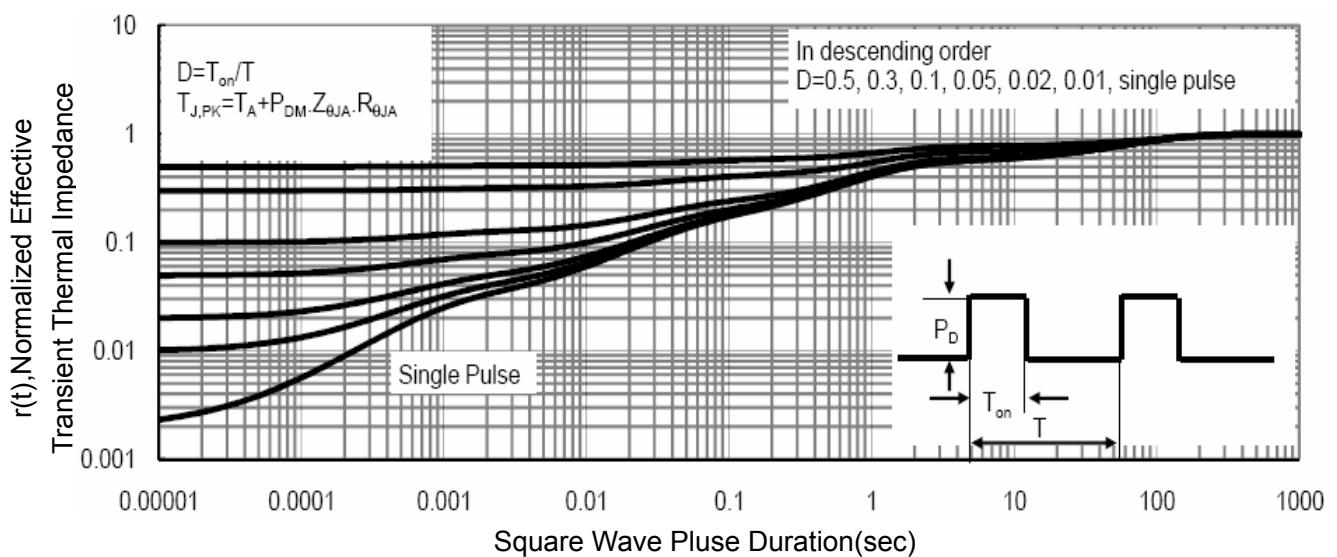


Figure 6 Source-Drain Diode Forward

**Figure 7 Capacitance vs Vds****Figure 9 Current De-rating****Figure 8 Safe Operation Area****Figure 10 Power De-rating****Figure 11 Normalized Maximum Transient Thermal Impedance**